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Fairchild Semiconductor FDB33N25TM

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November 2013

## **FDB33N25**

# N-Channel UniFET<sup>TM</sup> MOSFET 250 V, 33 A, 94 m $\Omega$

#### **Features**

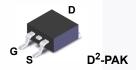
- $R_{DS(on)}$  = 94  $m\Omega$  (Max.) @  $V_{GS}$  = 10 V,  $I_D$  = 16.5 A
- Low Gate Charge (Typ. 36.8 nC)
- Low C<sub>rss</sub> (Typ. 39 pF)
- 100% Avalanche Tested

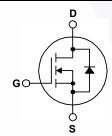
## **Applications**

- PDP TV
- Lighting
- · Uninterruptible Power Supply
- AC-DC Power Supply

## **Description**

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts





## **Absolute Maximum Ratings** T<sub>C</sub> = 25°C unless otherwise noted.

Symbol		FDB33N25	Unit	
V <sub>DSS</sub>	Drain-Source Voltage		250	V
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)	33 20.4	A A
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)	132	Α
V <sub>GSS</sub>	Gate-Source voltage	±30	V	
E <sub>AS</sub>	Single Pulsed Avalance	918	mJ	
I <sub>AR</sub>	Avalanche Current (Note 1)		33	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		23.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns
P <sub>D</sub>	Power Dissipation	(T <sub>C</sub> = 25°C) - Derate Above 25°C	235 1.89	W W/°C
T <sub>J,</sub> T <sub>STG</sub>	Operating and Storag	-55 to +150	°C	
T <sub>L</sub>	Maximum Lead Tempo	300	°C	

## **Thermal Characteristics**

Symbol	Parameter	FDB33N25	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max. 0.53		
R <sub>θJA</sub> *	Thermal Resistance, Junction-to-Ambient (1 in <sup>2</sup> Pad of 2-oz Copper), Max. 40		
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Minimum Pad of 2-oz Copper), Max.	62.5	



## **Package Marking and Ordering Information**

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FDB33N25TM	FDB33N25	D <sup>2</sup> -PAK	Tape and Reel	330 mm	24 mm	800 units

## **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Conditions	Min.	Тур.	Max	Unit	
Off Charac	Off Characteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	250			V	
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		0.25		V/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 200 V, T <sub>C</sub> = 125°C			1 10	μ <b>Α</b> μ <b>Α</b>	
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V	-		100	nA	
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA	
On Charac	On Characteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	3.0		5.0	V	
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 16.5 A		0.077	0.094	Ω	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> =16.5 A		26.6		S	
Dynamic C	Dynamic Characteristics						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1640	2135	pF	
C <sub>oss</sub>	Output Capacitance			330	430	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			39	59	pF	
Switching	Switching Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD}$ = 125 V, $I_{D}$ = 33 A, $V_{GS}$ = 10 V, $R_{G}$ = 25 $\Omega$ (Note 4)		35	80	ns	
t <sub>r</sub>	Turn-On Rise Time			230	470	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time			75	160	ns	
t <sub>f</sub>	Turn-Off Fall Time			120	250	ns	
$Q_g$	Total Gate Charge	V <sub>DS</sub> = 200 V, I <sub>D</sub> = 33 A,	/	36.8	48	nC	
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V (Note 4)		10		nC	
Q <sub>gd</sub>	Gate-Drain Charge			17		nC	
Drain-Sour	ce Diode Characteristics and Maximum	n Ratings					
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				33	Α	
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				132	Α	
$V_{SD}$	Drain-Source Diode Forward Voltage	e V <sub>GS</sub> = 0 V, I <sub>S</sub> = 33 A			1.4	V	
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 33 A,		220		ns	
Q <sub>rr</sub>	Reverse Recovery Charge	dl <sub>F</sub> /dt =100 A/μs	-	1.71		μС	

#### Notes:

- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. L = 1.35 mH, I $_{AS}$  = 33 A, V $_{DD}$  = 50 V, R $_{G}$  = 25  $\Omega$ , starting T $_{J}$  = 25°C.
- 3.  $I_{SD} \le 33$  A, di/dt  $\le 200$  A/ $\mu$ s,  $V_{DD} \le BV_{DSS}$ , starting  $T_J = 25^{\circ}C$ .
- 4. Essentially independent of operating temperature typical characteristics.



## **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

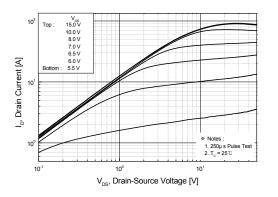


Figure 2. Transfer Characteristics

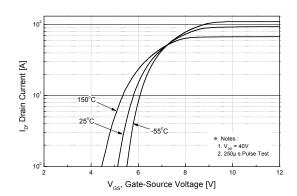
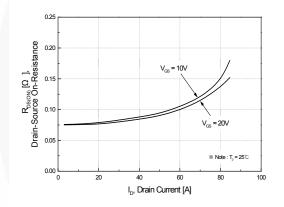


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue



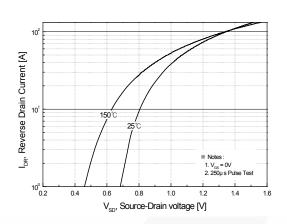


Figure 5. Capacitance Characteristics

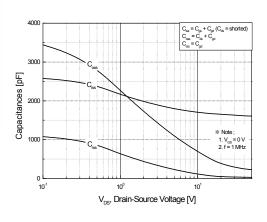
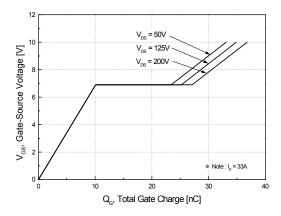


Figure 6. Gate Charge Characteristics





## **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

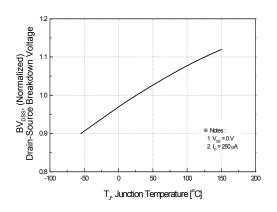


Figure 8. On-Resistance Variation vs. Temperature

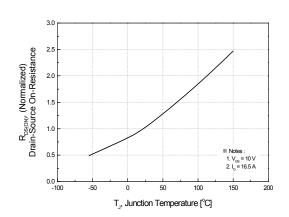


Figure 9. Maximum Safe Operating Area

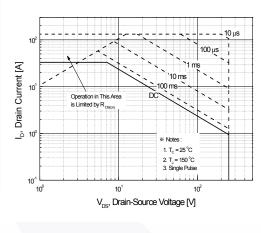


Figure 10. Maximum Drain Current vs. Case Temperature

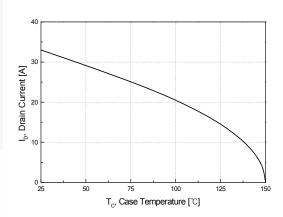
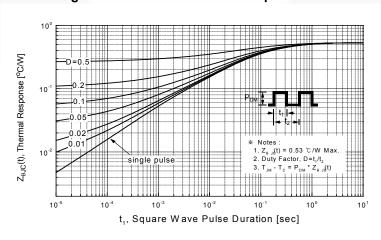


Figure 11. Transient Thermal Response Curve





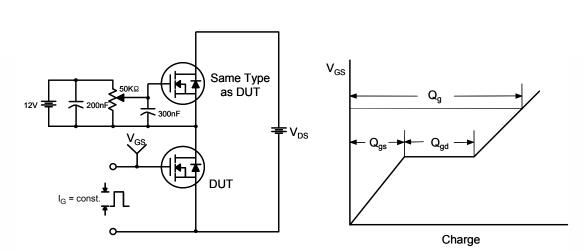


Figure 12. Gate Charge Test Circuit & Waveform

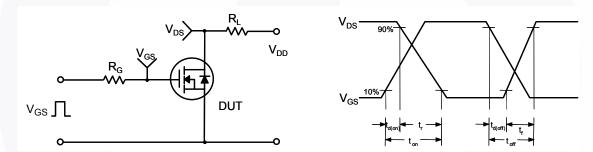


Figure 13. Resistive Switching Test Circuit & Waveforms

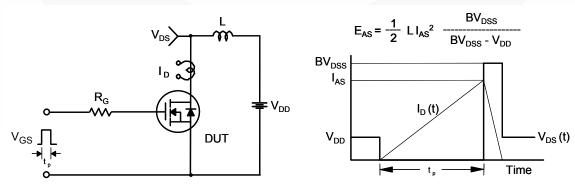


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



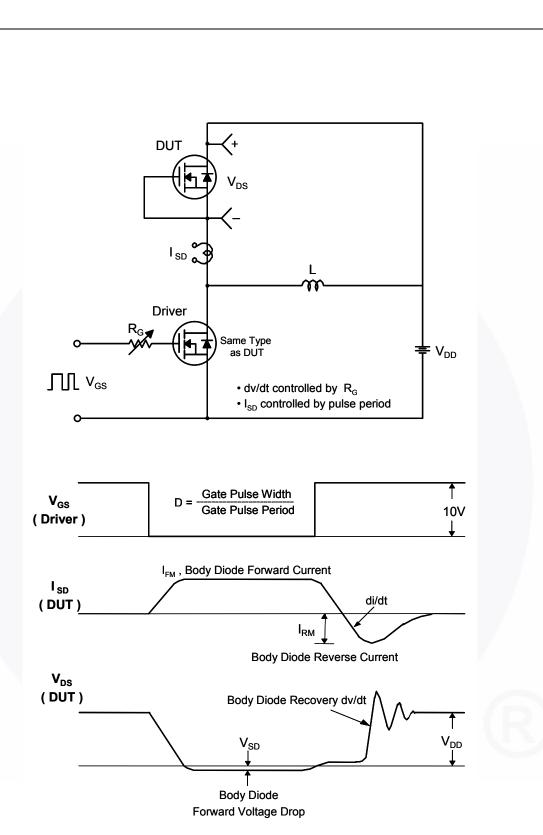


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

#### **Mechanical Dimensions**

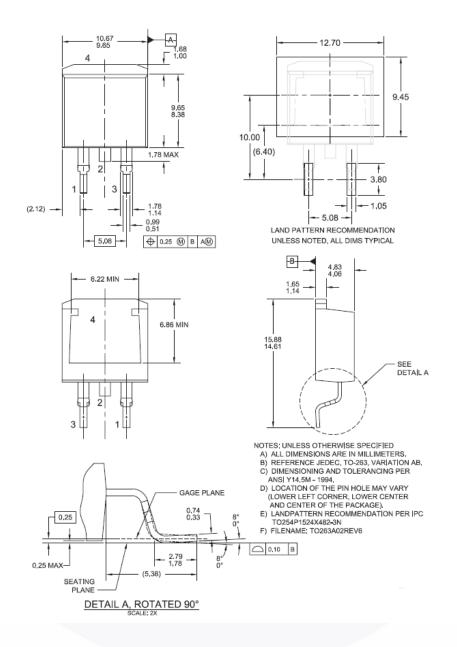


Figure 16. TO263 (D<sup>2</sup>PAK), Molded, 2-Lead, Surface Mount

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